## Notice of References Cited Application/Control No. 09/752,667 Examiner Nhon T. Diep Applicant(s)/Patent Under Reexamination KIM ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,490,627	12-2002	Kalra et al.	709/231
	В	US-			
	С	US-			
	D	US-			
	E	US-			
	·F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
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## FOREIGN PATENT DOCUMENTS

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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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